

Application/Control No.	Applicant(s)/Patent Reexamination	under
10/657,847	LIU ET AL.	
Examiner	Art Unit	
Khanh B. Duong	2822	

SEARCHED						
Class		Subclass	Date		Examiner	
438		780	6/25	/2005	K	BD
		781				
		622				
		623				
		758				
		759				
		631				
		637				
		627				
		633-635				
		691				
		692				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
438	all above	6/25/2005	KBD	
	<u> </u>	-		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST update	6/28/2005	KBD		
Inventor Name Search	6/27/2005	KBD		
Discussed w/ Primary Examiner Jack Chen (AU 2813)	6/25/2005	KBD		
Discussed w/ Primary Examiner Maria Guerrero & Mike Trinh	7/7/2005	KBD		